



30V P-CHANNEL ENHANCEMENT MODE MOSFET POWERDI®

Product Summary

V _{(BR)DSS}	R _{DS(ON)} max	I _D max T _A = 25°C
	$20m\Omega$ @ $V_{GS} = -10V$	-9.5 A
-30V	29mΩ @ V _{GS} = -5V	-8.5 A

Description and Applications

This MOSFET has been designed to minimize the on-state resistance $(R_{DS(on)})$ and yet maintain superior switching performance, making it ideal for high efficiency power management applications.

- Backlighting
- Power Management Functions
- DC-DC Converters

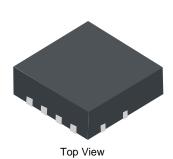
Features and Benefits

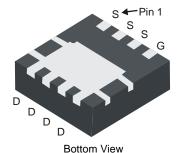
- Low R_{DS(ON)} ensures on state losses are minimized
- Small form factor thermally efficient package enables higher density end products
- Occupies just 33% of the board area occupied by SO-8 enabling smaller end product
- Totally Lead-Free & Fully RoHS Compliant (Notes 1 & 2)
- Halogen and Antimony Free. "Green" Device (Note 3)
- Qualified to AEC-Q101 Standards for High Reliability

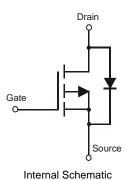
Mechanical Data

- Case: POWERDI3333-8
- Case Material: Molded Plastic, "Green" Molding Compound. UL Flammability Classification Rating 94V-0
- Moisture Sensitivity: Level 1 per J-STD-020
- Terminal Connections Indicator: See diagram
 Terminals: Finish Matte Tin annealed over Copper leadframe.

 Solderable per MIL-STD-202, Method 208 (3)
- Weight: 0.072 grams (approximate)







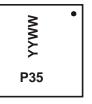
Ordering Information (Note 4)

Part Number	Case	Packaging		
DMP3035SFG-7	POWERDI3333-8	2000/Tape & Reel		
DMP3035SFG-13	POWERDI3333-8	3000/Tape & Reel		

Notes:

- 1. No purposely added lead. Fully EU Directive 2002/95/EC (RoHS) & 2011/65/EU (RoHS 2) compliant.
- 2. See http://www.diodes.com for more information about Diodes Incorporated's definitions of Halogen- and Antimony-free, "Green" and Lead-free.
- 3. Halogen- and Antimony-free "Green" products are defined as those which contain <900ppm bromine, <900ppm chlorine (<1500ppm total Br + Cl) and <1000ppm antimony compounds.
- 4. For packaging details, go to our website at http://www.diodes.com.

Marking Information



P35 = Product Type Marking Code YYWW = Date Code Marking YY = Last digit of year (ex: 11 = 2011) WW = Week code (01 ~ 53)

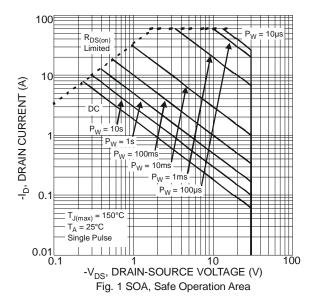


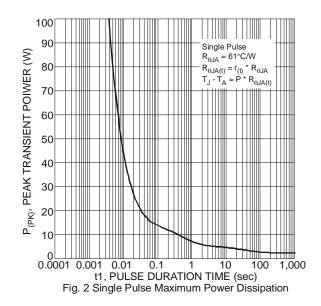
Maximum Ratings @TA = 25°C unless otherwise specified

Characteristic	Symbol	Value	Units		
Drain-Source Voltage	V _{DSS}	-30	V		
Gate-Source Voltage	V _{GSS}	±25	V		
Continuous Dusin Compant (Nata C) V	Steady State	T _A = 25°C T _A = 70°C	I _D	-8.5 -6.7	А
Continuous Drain Current (Note 6) V _{GS} = -10V	t<10s	T _A = 25°C T _A = 70°C	I _D	-12.5 -10.0	А
Continuous Davis Compant (Nata C) V	Steady State	T _A = 25°C T _A = 70°C	I _D	-7.0 -5.5	А
Continuous Drain Current (Note 6) V _{GS} = -5V	t<10s	T _A = 25°C T _A = 70°C	ID	-10.0 -8.0	А
Pulsed Drain Current (10µs pulse, duty cycle = 1%)	I _{DM}	-70	Α		
Maximum Continuous Body Diode Forward Current	I _S	-3.6	Α		

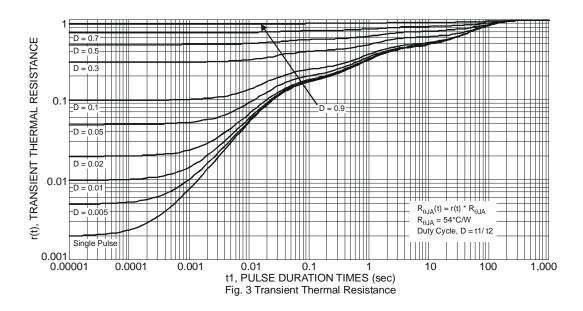
Thermal Characteristics @TA = 25°C unless otherwise specified

Characteristic	Symbol	Value	Units	
Total Power Dissipation (Note 5)		P_{D}	0.95	W
Thermal Resistance, Junction to Ambient (Note 5)	Steady state	ס	135	°C/W
Thermal Resistance, Junction to Ambient (Note 5)	t<10s	$R_{\theta JA}$	65	°C/W
Total Power Dissipation (Note 6)	P_D	2.3	W	
Thermal Resistance, Junction to Ambient (Note 6)	Steady state	ס	55	°C/W
Thermal Resistance, Junction to Ambient (Note 6)	t<10s	$R_{ heta JA}$	26	°C/W
Thermal Resistance, Junction to Case (Note 6)	$R_{ heta JC}$	6.14	°C/W	
Operating and Storage Temperature Range	$T_{J_i}T_{STG}$	-55 to +150	°C	









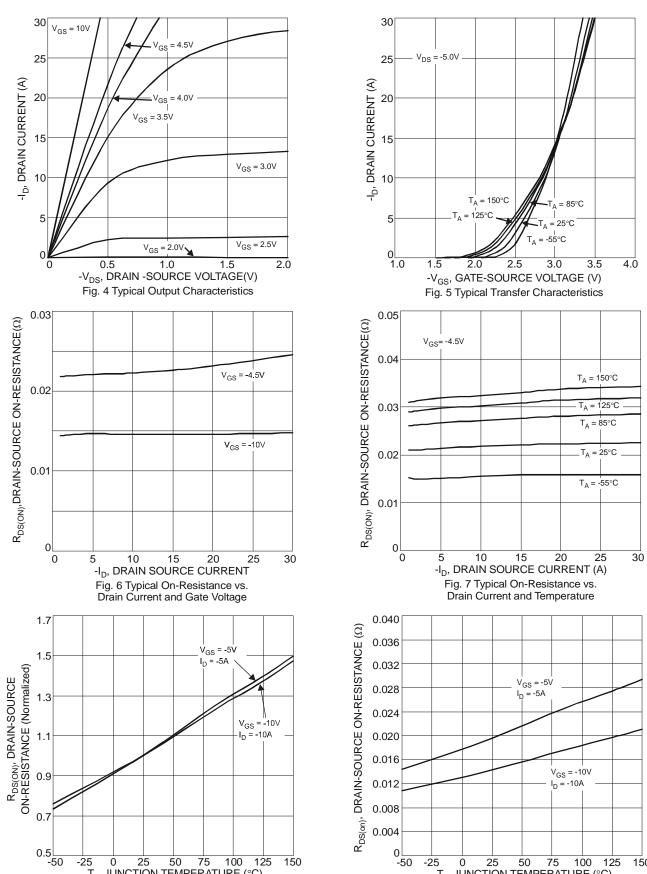
Electrical Characteristics T_A = 25°C unless otherwise specified

Characteristic	Symbol	Min	Тур	Max	Unit	Test Condition	
OFF CHARACTERISTICS (Note 7)							
Drain-Source Breakdown Voltage	BV _{DSS}	-30	-	-	V	$V_{GS} = 0V$, $I_D = -250\mu A$	
Zero Gate Voltage Drain Current	I _{DSS}	-	-	-1.0	μΑ	$V_{DS} = -30V, V_{GS} = 0V$	
Gate-Source Leakage	I _{GSS}	-	-	±100	nA	$V_{GS} = \pm 25V, V_{DS} = 0V$	
ON CHARACTERISTICS (Note 7)	a .						
Gate Threshold Voltage	$V_{GS(th)}$	-1.0	-1.7	-2.5	V	$V_{DS} = V_{GS}, I_{D} = -250 \mu A$	
Static Drain-Source On-Resistance		-	15	20	mΩ	$V_{GS} = -10V, I_D = -8A$	
Static Drain-Source On-Resistance	R _{DS (ON)}	-	21	29	11122	$V_{GS} = -5V, I_D = -5A$	
Forward Transfer Admittance	Y _{fs}	-	22	-	S	$V_{DS} = -5V, I_{D} = -10.0A$	
Diode Forward Voltage	V_{SD}	-	-0.74	-1.0	V	$V_{GS} = 0V, I_{S} = -1A$	
DYNAMIC CHARACTERISTICS (Note 8)							
Input Capacitance	C _{iss}	-	1633	-	pF		
Output Capacitance	Coss	-	459	-	pF	$V_{DS} = -15V, V_{GS} = 0V,$ - f = 1.0MHz	
Reverse Transfer Capacitance	Crss	-	214	-	pF	1 = 1:0W112	
Gate Resistance	Rg	-	6.5	13	Ω	$V_{DS} = 0V$, $V_{GS} = 0V$, $f = 1MHz$	
Total Gate Charge V _{GS} = -4.5V	Q_{g}	-	17	-	nC	V _{DS} = -15V, V _{GS} = -10V, I _D = 8A	
Total Gate Charge V _{GS} = -10V	Q_g	-	35.5	-	nC		
Gate-Source Charge	Q _{gs}	-	4.6	-	nC		
Gate-Drain Charge	Q_{gd}	-	5.7	-	nC		
Turn-On Delay Time	t _{D(on)}	-	8.5	-	ns		
Turn-On Rise Time	t _r	-	14	-	ns	$V_{GEN} = -10V, V_{DD} = -15V,$	
Turn-Off Delay Time	t _{D(off)}	-	50	-	ns	$R_{GEN} = 3\Omega$, $I_D = -15A$	
Turn-Off Fall Time	t _f	-	25.8	-	ns		

Notes:

- Device mounted on FR-4 substrate PC board, 2oz copper, with minimum recommended pad layout.
 Device mounted on FR-4 substrate PC board, 2oz copper, with 1inch square copper plate.
 Short duration pulse test used to minimize self-heating effect.
 Guaranteed by design. Not subject to product testing.





25

50

T_{.I}, JUNCTION TEMPERATURE (°C)

Fig. 8 On-Resistance Variation with Temperature

75

100 125

-50

25

50

T_J, JUNCTION TEMPERATURE (°C)

Fig. 9 On-Resistance Variation with Temperature

75

100 125



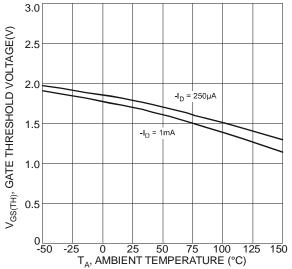
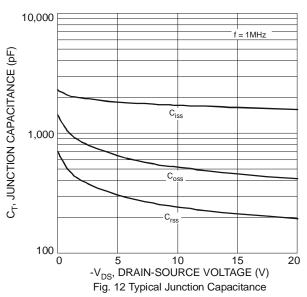
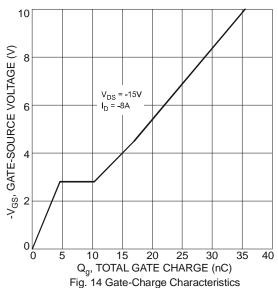
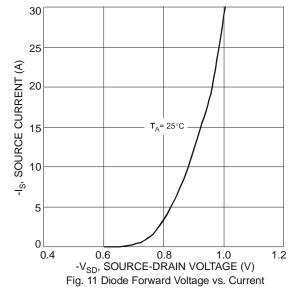


Fig. 10 Gate Threshold Variation vs. Ambient Temperature







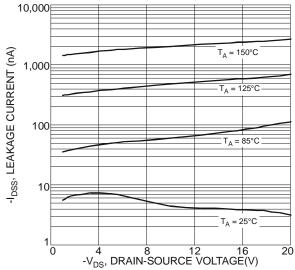
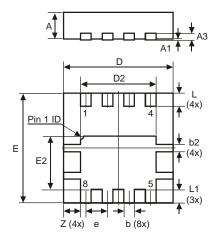


Fig. 13 Typical Drain-Source Leakage Current vs. Voltage

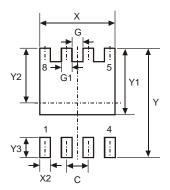


Package Outline Dimensions



POWERDI3333-8					
Dim	Min	Max	Тур		
D	3.25	3.35	3.30		
Е	3.25	3.35	3.30		
D2	2.22	2.32	2.27		
E2	1.56	1.66	1.61		
Α	0.75	0.85	0.80		
A1	0	0.05	0.02		
А3	_	-	0.203		
b	0.27	0.37	0.32		
b2	-	-	0.20		
L	0.35	0.45	0.40		
L1	-	-	0.39		
е	_	_	0.65		
Ζ	_	_	0.515		
All Dimensions in mm					

Suggested Pad Layout



Dimensions	Value (in mm)				
C	0.650				
G	0.230				
G1	0.420				
Y	3.700				
Y1	2.250				
Y2	1.850				
Y3	0.700				
X	2.370				
X2	0.420				



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